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Collider Accelerator Department Brookhaven National Laboratory

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Emittance Measurements using Vernier Scans during Run 09 (pp at 250 GeV)

A. Drees

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1 Vernier Scan Technique

During the 250 GeV PP run in 09 a total of 9 vernier scans [1] were performed. The transverse size and shape of the beam overlap region is measured by recording the relative interaction rates as a function of the transverse beam separation. A fit of the measured interaction rates as a function of the separation will allow to determine the effective beam size as well as the maximum achievable collision rate and the effective cross section (see eq. 2). In reality additional effects such as crossing angle or hourglass effect [2] require correction factors to be applied and will have to be taken into account when computing the systematic error. Table 1 lists the fills with vernier scans together with the hour glass factors achieved at the time of the vernier scans, the fill pattern and the number of colliding bunch pairs in IR8 and IR6. Some fills include scans in both IR's while others include a scan in one IR only. Either way, however, each of those fills will give us a beam emittance measurement.

fill	hourglass factor	IR	fill pattern	# coll. pairs IR8	IR6
10207	0.72	IR6&8	54x56	54	50
10276	0.64	IR6&8	56x56	56	52
10325	0.64	IR8	84x84	82	77
10399	0.68	IR6	83x83	80	75
10415	0.68	IR6&8	109x108	106	101
10478	0.70	IR8	109x107	105	100
10505	0.65	IR8	109x106	104	99
10507	0.73	IR6	108 x 106	103	98
10536	0.72	IR6&8	106 x 106	101	96

Table 1: List of fills with vernier scans during the 250 GeV '09 proton run.

The definition of luminosity assumes perfectly Gaussian beams. In hadron machines, where the damping is very low, this is not always the case and non-Gaussian tails can appear. This was first observed in RHIC during the 250 GeV pp run ([3]). These non-Gaussian components of the beam still contribute to the overall luminosity and have to be taken into account while computing the overlap area width.



Figure 1: Horizontal beam profile as measured from the ZDC in PHENIX during the 10415 scan. A simple 1-Gauss-fit, truncated at \pm 0.5 mm, (red line) is applied.



Figure 2: Horizontal beam profile as measured from the ZDC in PHENIX during the 10415 scan. A double Gauss-fit (red line) is applied.

The core of the beam, which remained Gaussian during run09, is the main contributor to the luminosity. A convenient way to include the tails in the model is to fit the profile with a double Gaussian. Figure 1 shows a fit to the data from store 10415 (PHENIX). Here a 1-Gauss fit, truncated to \pm 0.5 mm is shown, resulting in a width of the overlap region of 0.19 mm.

Figure 2, however, shows a fit to the same data as shown in figure 1 to the left, but applying a double Gauss fit. The resulting widths are 0.18 mm and 0.31 mm respectively. These widths are combined to an effective width σ_{eff} according to:

$$\sigma_{eff} = \frac{1stWidth * 1stMax + 2ndWidth * 2ndMax}{1stMax + 2ndMax} \tag{1}$$

Combining the widths from the given example and using their individual relative maxima (72330 Hz and 7451 Hz respectively) we get an effective width of 0.195 mm, which is in good agreement with the result from the truncated 1-Gauss fit (figure 1). This indicates that the contribution from the second Gauss to the effective width is small and not significant although the two fits disagree obviously in the tail area as can easily be seen in figure 3. Comparing the two different fits as shown in figure 3 for another example, here fill 10536, demonstrates that a 1-Gauss fit does not describe the tails of the data while a double Gauss does. Both, however, fit the core portion of the profile well. Since both methods, truncating the 1-Gauss approach as well as the double Gauss fit to the whole range of separation, give similar results, they could both be used to determine the beam emittance. In the following we have combined the results from both methods while adding the range of variation between the two methods as a systematic error resulting in an overall $\pm 2\pi$ mm mrad error. However, the variation of the individual results per fill is typically small and in the order of 5% or less.

2 Emittance Measurements

2.1 Vernier Scans

From the fit to the vernier scan data the RMS beam size $\sigma_{x,y}$ as well as the effective cross section σ_{pp}^{ZDC} of a detector, in this case the ZDCs, can be derived:

$$\sigma_{pp}^{ZDC} = \frac{R_{max} \ 2\pi \ n_B \ n_Y \ \sigma_x^{VS} \ \sigma_y^{VS}}{n_{coll} \ f_{rev} \ N_B \ N_Y} \tag{2}$$



Figure 3: Profile measured by the ZDCs in PHENIX during the 10536 store showing both, a simple 1-Gauss fit (blue line) and a double Gauss fit (red line). Results from the double Gauss fit are included. The collision rate is normalized by the total beam current.

where:

 R_{max} = maximum collision rate seen by the ZDC detector (corrected for background) n_B, n_Y = number of blue and yellow bunches respectively $\sigma_{x,y}^{VS}$ = RMS beam-overlap size, derived from the fit to the vernier scan data n_{coll} = number of colliding bunch pairs in the IP where the ZDC detector is located f_{rev} = revolution frequency, 78.4 kHz $N_{B,Y}$ = total number of blue and yellow protons

Given the RMS beam size we can calculate the normalized beam emittance $\epsilon_{norm}^{x,y}$ assuming that the beam sizes are the same in the two rings:

$$\epsilon_{norm}^{x,y} = \frac{6 \ (\sigma_{x,y}^{VS})^2 \ \gamma}{2 \ \beta^*} \tag{3}$$

with $\gamma = 266.3$ for 250 GeV protons.

2.2 IPM

At the same time the IPM detectors provide an equivalent measurement, not only at specific times but continuously during the store. As can be seen in figure 4, top, a constant is a good fit to the emittance as a function of time for the time span of 30 minutes (the duration of the vernier scan, shown in the bottom graph). The conclusion from figure 4 applies to all stores with vernier scans. There is practically no visible slope in the emittance data during the times of the vernier scans. Also typical are the differences between the rings and planes as apparently seen by the IPM. The results from the IPMs are listed together with the results from the vernier scans and from the collision rate ([4]) in table 2 below. The typical scatter of the IPM measurements indicates an error of about 3 π mm mrad, which was used in the following.

2.3 Emittance from Collision Rate

In order to compute the beam size from the collision rate an effective cross section is needed. Combining eq. 2 and eq. 3 from above, one can compute the normalized emittance



Figure 4: Emittance measurements from the IPM detector during the vernier scans in IR6 and IR8, fill 10536. Top: IPM data, bottom: ZDC coincidence rates in STAR and PHENIX. A constant fit was applied to the IPM data resulting in normalized emittances of 26, 18, 36 and 15 π mm mrad at the time of the vernier scan in PHENIX.

 ϵ_{norm}^{coll} from the collision rate:

$$\epsilon_{norm}^{coll} = \frac{6 \gamma}{\beta^*} \frac{\sigma^{ZDC} n_{coll} f_{rev} N_B N_Y}{R_{coll} 2\pi n_B n_Y} \tag{4}$$

For this to work the following assumptions were made: the beam size in the two rings and both planes are effectively identical, beams are colliding head-on, $\beta^* = 0.7$ m and we know the effective cross section. In this analysis two values, 2.1 and 2.4 mbarn, were used as σ^{ZDC} and the mean value is used in the following (referred to as "StoreAna" in table 2) with the average spread as the error bars shown in fig. 5 and 6.

3 Discussion

All fit results are summarized in table 2. The fit results from the double Gauss fit are all slightly larger than the results from the truncated simple Gauss fit. This is consistent with an effective beam size which is, however mildly, somewhat enlarged due to the non-Gaussian tails. However, the differences between fit functions as well as the two planes have the same order of magnitude as the error bar of $\pm 2 \pi$ mm mrad. The results from the fits to the vernier scan data clearly show that we have round beams, hence the various results are all combined into one, labeled "Avg.".

On the other hand, the IPM data, shown in the last 4 columns, are consistent with beams that are larger in the horizontal plane than in the vertical one by about a factor 2-3 (depending on the ring). Therefore they were not averaged into one number and could not easily be compared with the emittance derived from collision rates (1st column). The results presented in table 2 are depicted in figure 5 and 6.

fill	StoreAna	Vernier Scans				Avg.	IPM			
		ϵ_{H}^{1G}	ϵ_V^{1G}	ϵ_{H}^{2G}	ϵ_V^{2G}		BH	BV	YH	YV
10207	44.5	42.5	45.5	43.0	46	44	61	43	34	18
10276	31	28	29.5	29	31	29	44	34	45	14
10325	19	20.5	22	22	23	22	29	22	33	13
10399	21	20	19	21	20	20	24	19	29	12
10415	30.5	29	29	30	29	29	33	26	40	17
10478	19	18	21	18	20	19	23	14	26	11
10505	20.5	18	21.5	19.5	21.5	20	25	16	31	12
10507	18	19	18	19	18	18	23	12	27	11
10536	26.5	22	24	24	25	24	26	18	36	15

Table 2: Normalized beam emittance derived from collision rates [4], vernier scans and IPM detector in units of π mm mrad. In this analysis we assume $\beta^* = 0.7m$.

Fig. 5 top shows the individual fit results from the vernier scan data (both planes, both fit functions). The results from the 1-Gauss fit are shown in red, the results from the double Gauss fit are shown in green. Black data points represent the effective beam size computed from the collision rate according to eq. 4. The agreement between the two fitting approaches as well as the methods is very good, all give basically the same answer. There is no systematic discrepancy between the two methods indicating that a $\beta^* = 0.7$ m is a good approximation for the 'true' value since no a priori knowledge of β^* is needed in the vernier scan analysis. The measurements are all consistent with round beams and emittances between 18 and 45 π mm mrad. The bottom plot compares the emittance from averaged vernier scan results (green data points, "VS ave.") with the data from the IPM (obviously labeled). The disagreement is quite large.

Figure 6 compares the IPM data from the horizontal (top) and vertical (bottom) plane with the vernier scan data separately. The top graph presents the horizontal emittance measurements from the double Gauss fit to the vernier scan data ("2GH Vscan") together with the blue and yellow IPM measurements in the same plane. The equivalent for the vertical plane is shown in the bottom graph. In both planes the disagreement with the vernier scan data is quite large. However, beginning with fill 10325, the blue IPM agree much better with the vernier scan data though the horizontal measurements are systematically above and the vertical measurements are systematically below the vernier scan results. This discrepancy is much more pronounced with the yellow IPM measurements which are clearly inconsistent with a round-beam assumption. Parts of that discrepancy could probably be explained by an uncertainty of the beta function at the location of the IPM. If so, the ratio between the two methods would, if not be 1, be constant and not vary from fill to fill. Ignoring the first two data sets, which seem to be particularly off, the ratio between the two methods (VS versus IPM) varies between 0.77 and 0.91 in Blue horizontal and between 0.63 and 0.75 in Yellow. Therefore there is a 25% to 35% disagreement that is not quite constant but varies within 20% from fill to fill. The picture is similar in the vertical plane. In Blue the ratios vary from 1.04 to 1.46 with a 30% fill to fill scatter. In Yellow, where the disagreement with up to 80% between the methods is the largest, the



Figure 5: Emittances from vernier scans and collision rate during Run09 pp at 250 GeV vs. fill number.

ratio ranges from 1.59 to 1.79 with a 10% fill to fill scatter.

4 Conclusion

Emittance measurements using the vernier scan technique give reliable results for 250 GeV protons even though the transverse beam profiles have non-Gaussian tails. Those non-Gaussian tails were observed for the first time this run at the 250 GeV beam energy.

The vernier scan measurements are in excellent agreement with the emittances derived from collision rates and show practically no fill to fill scatter if compared to the latter. The results are consistent with a β^* of 0.7 m and round beams.

The IPM measurements show a discrepancy of up to 80% compared with the vernier scan data and a fill to fill scatter of up to 30%. If an uncertainty in the beta-function at the location of the IPM is the root cause, this uncertainty seems to be quite large. In any case, such an uncertainty could not explain the fill to fill variations of up to 30% which indicate



Figure 6: Horizontal (top) and vertical (bottom) normalized emittance measurements as a fct. of fill number combining data from vernier scans and IPM.

yet another underlying reason that could explain fill to fill variations (candidates could be beam intensity issues with the IPM, beam position at the IPM, varying background etc.).

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